

<b>Notice of References Cited</b>		Application/Control No. 10/814,198	Applicant(s)/Patent Under Reexamination YOON ET AL.	
		Examiner Michael P. Choi	Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0057372	05-2002	Cavallerano et al.	348/565
*	B	US-2003/0016304 A1	01-2003	NORSWORTHY et al.	348/565
*	C	US-2003/0099457	05-2003	Takahashi et al.	386/46
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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